Almost k-wise independence versus k-wise independence

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Abstract

We say that a distribution over $\{0,1\}^n$ is (ϵ, k) -wise independent if its restriction to every k coordinates results in a distribution that is ϵ -close to the uniform distribution. A natural question regarding (ϵ, k) -wise independent distributions is how close they are to some k-wise independent distribution. We show that there exists (ϵ, k) -wise independent distribution whose statistical distance is at least $n^{O(k)} \cdot \epsilon$ from any k-wise independent distribution. In addition, we show that for any (ϵ, k) -wise independent distribution there exists some k-wise independent distribution.

Keywords: Small probability spaces, k-wise independent distributions, almost k-wise independent distributions, small bias probability spaces.

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1 Introduction

Small probability spaces of limited independence are useful in various applications. Specifically, as observed by Luby [4] and others, if the analysis of a randomized algorithm only relies on the hypothesis that some objects are distributed in a k-wise independent manner then one can replace the algorithm's random-tape by a string selected from a k-wise independent distribution. Recalling that k-wise independent distributions over $\{0,1\}^n$ can be generated using only $O(k \log n)$ bits (see, e.g., [1]), this yields a significant saving in the randomness complexity and also leads to a derandomization in time $n^{O(k)}$. (This number of random bits is essentially optimal; see [3], [1].)

Further saving is possible whenever the analysis of the randomized algorithm can be carried out also in case its random-tape is only "almost k-wise independent" (i.e., (ϵ, k) -wise distribution where every k bits are distributed ϵ -close to uniform). This is because (ϵ, k) -wise distributions can be generated using fewer random bits (i.e., $O(k + \log(n/\epsilon))$ bits suffice, where ϵ is the variation distance of these k-projections to the uniform distribution): See the work of Naor and Naor [5] (as well as subsequent simplifications in [2]).

Note that, in both cases, replacing the algorithm's random-tape by strings taken from a distribution of a smaller support requires verifying that the original analysis still holds for the replaced distribution. It would have been nicer, if instead of re-analyzing the algorithm for the case of (ϵ, k) -wise independent distributions, we could just re-analyze it for the case of k-wise independent distributions and apply a generic result. This would imply that the randomized algorithm can be further derandomized using an (ϵ, k) -wise independent distribution. Such a result may say that if the algorithm behaves well under any k-wise independent distribution then it would behave essentially as well also under any almost k-wise independent distribution, provided that the parameter ϵ governing this measure of closeness is small enough. Of course, the issue is how small ϵ should be.

A generic approach towards the above question is to ask: What is the statistical distance δ between arbitrary almost k-wise independent distribution and some k-wise independent distribution? Specifically, how does this distance δ depend on n and k (and on the parameter ϵ)? Note that we will have to set ϵ sufficiently small so that δ will be small (e.g., $\delta = 0.1$ may do).

Our original hope was that $\delta = \text{poly}(2^k, n) \cdot \epsilon$ (or $\delta = \text{poly}(2^k, n) \cdot \epsilon^{1/O(1)}$). If this had been the case, we could have set $\epsilon = \text{poly}(2^{-k}, n^{-1}, \delta)$, and use an almost k-wise independent sample space of size $\text{poly}(n/\epsilon) = \text{poly}(2^k, n, \delta^{-1})$ (instead of size $n^{\Theta(k)}$ as for perfect k-wise independence). Unfortunately, the answer is that $\delta = n^{\Theta(k)} \cdot \epsilon$, and so this generic approach (which requires setting $\epsilon = \delta/n^{\Theta(k)}$ and using a sample space of size $\Omega(1/\epsilon) = n^{\Theta(k)}$) does not lead to anything better than just using an adequate k-wise independent sample space. In fact we show that every distribution with support less than $n^{\Theta(k)}$ has large statistical distance to any k-wise independent distribution.

2 Formal Setting

We consider distributions and random variables over $\{0,1\}^n$, where n (as well as k and ϵ) is a parameter. A distribution D_X over $\{0,1\}^n$ assigns each $z \in \{0,1\}^n$ a value $D_X(z) \in [0,1]$ such that $\sum_z D_X(z) = 1$. A random variable X over $\{0,1\}^n$ is associated with a distribution D_X and randomly selects a $z \in \{0,1\}^n$, where $\Pr[X = z] = D_X(z)$. Throughout the paper we use interchangeably the notation of a random variable and a distribution. The statistical distance, denoted $\Delta(X, Y)$, between two random variables X and Y over $\{0,1\}^n$ is defined as

$$\Delta(X,Y) \stackrel{\text{def}}{=} \frac{1}{2} \cdot \sum_{z \in \{0,1\}^n} |\Pr[X = z] - \Pr[Y = z]|$$

$$= \max_{S \subset \{0,1\}^n} \{ \Pr[X \in S] - \Pr[Y \in S] \}.$$

If $\Delta(X,Y) \leq \epsilon$ we say that X is ϵ -close to Y. (Note that $2\Delta(X,Y)$ equals to $||D_X - D_Y||_1 = \sum_{z \in \{0,1\}^n} |D_X(z) - D_Y(z)|$.)

A distribution $X = X_1 \cdots X_n$ is called an (ϵ, k) -approximation if for every k (distinct) coordinates $i_1, \ldots, i_k \in \{1, \ldots, n\}$ it holds that $X_{i_1} \cdots X_{i_k}$ is ϵ -close to the uniform distribution over $\{0, 1\}^k$. A (0, k)-approximation is sometimes referred to as a k-wise independent distribution (i.e., for every k (distinct) coordinates $i_1, \ldots, i_k \in \{1, \ldots, n\}$ it holds that $X_{i_1} \cdots X_{i_k}$ is uniform over $\{0, 1\}^k$.

A related notion is that of having bounded bias on (non-empty) sets of size at most k. Recall that the bias of a distribution $X = X_1 \cdots X_n$ on a set I is defined as

bias_I(X)
$$\stackrel{\text{def}}{=} \mathsf{E}[(-1)^{\sum_{i \in I} X_i}]$$

= $\mathsf{Pr}[\oplus_{i \in I} X_i = 0] - \mathsf{Pr}[\oplus_{i \in I} X_i = 1] = 2\mathsf{Pr}[\oplus_{i \in I} X_i = 0] - 1.$

Clearly, for any (ϵ, k) -approximation X, the bias of the distribution X on every non-empty subset of size at most k is bounded above by 2ϵ . On the other hand, if X has bias at most ϵ on every non-empty subset of size at most k then X is a $(2^{k/2} \cdot \epsilon, k)$ -approximation (see [7] and the Appendix in [2]).

Since we are willing to give up on $\exp(k)$ factors, we state our results in terms of distributions of bounded bias.

Theorem 2.1 (Upper Bound): Let $X = X_1...,X_n$ be a distribution over $\{0,1\}^n$ such that the bias of X on any non-empty subset of size up to k is at most ϵ . Then X is $\delta(n,k,\epsilon)$ -close to some k-wise independent distribution, where $\delta(n,k,\epsilon) \stackrel{\text{def}}{=} \sum_{i=1}^k {n \choose i} \cdot \epsilon \leq n^k \cdot \epsilon$.

The proof appears in Section 3.1. It follows that any (ϵ, k) -approximation is $\delta(n, k, \epsilon)$ -close to some (0, k)-approximation. (We note that our construction is not efficient both in its computation time and in the number of random bits, and its main purpose is to generate some k-wise independent distribution.) We show that the above result is nearly tight in the following sense.

Theorem 2.2 (Lower Bound): For every n, every even k and every ϵ such that $\epsilon > 2k^{k/2}/n^{(k/4)-1}$ there exists a distribution X over $\{0,1\}^n$ such that

- 1. The bias of X on any non-empty subset is at most ϵ .
- 2. The distance of X from any k-wise independent distribution is at least $\frac{1}{2}$.

The proof appears in Section 3.2. In particular, setting $\epsilon = n^{-k/5}/2$ (which, for sufficiently large $n \gg k \gg 1$, satisfies $\epsilon > 2k^{k/2}/n^{(k/4)-1}$), we obtain that $\delta(n, k, \epsilon) \ge 1/2$, where $\delta(n, k, \epsilon)$ is as in Theorem 2.1. Thus, if $\delta(n, k, \epsilon) = f(n, k) \cdot \epsilon$ (as is natural and is indeed the case in Theorem 2.1) then it must hold that

$$f(n,k) \geq \frac{1}{2\epsilon} = n^{k/5}.$$

A similar analysis holds also in case $\delta(n, k, \epsilon) = f(n, k) \cdot \epsilon^{1/O(1)}$. We remark that although Theorem 2.2 is shown for an even k, a bound for an odd k can be trivially derived by replacing k by k - 1.

3 Proofs

3.1 Proof of Theorem 2.1

Going over all non-empty sets, I, of size up to k, we make the bias over these sets zero, by augmenting the distribution as follows. Say that the bias over I is exactly $\epsilon > 0$ (w.l.o.g., the bias is positive); that is, $\Pr[\bigoplus_{i \in I} X_i = 0] = (1 + \epsilon)/2$. Then (for $p \approx \epsilon$ to be determined below), we define a new distribution $Y = Y_1...Y_n$ as follows.

- 1. With probability 1 p, we let Y = X.
- 2. With probability p, we let Y be uniform over the set $\{\sigma_1 \cdots \sigma_n \in \{0,1\}^n : \bigoplus_{i \in I} \sigma_i = 1\}$.

Then $\Pr[\bigoplus_{i \in I} Y_i = 0] = (1-p) \cdot ((1+\epsilon)/2) + p \cdot 0$. Setting $p = \epsilon/(1+\epsilon)$, we get $\Pr[\bigoplus_{i \in I} Y_i = 0] = 1/2$ as desired. Observe that $\Delta(X, Y) \leq p < \epsilon$ and that we might have only decreased the biases on all other subsets. To see the latter, consider a non-empty $J \neq I$, and notice that in Case (2) Y is unbiased over J. Then

$$\begin{aligned} \left| \Pr[\oplus_{i \in J} Y_i = 1] - \frac{1}{2} \right| &= \left| \left((1-p) \cdot \Pr[\oplus_{i \in J} X_i = 1] + p \cdot \frac{1}{2} \right) - \frac{1}{2} \right| \\ &= (1-p) \cdot \left| \Pr[\oplus_{i \in J} X_i = 1] - \frac{1}{2} \right|, \end{aligned}$$

and the theorem follows.

3.2 Proof of Theorem 2.2

On one hand, we know (cf., [2], following [5]) that there exists ϵ -bias distributions of support size $(n/\epsilon)^2$. On the other hand, we will show (in Lemma 3.1) that every k-wise independent distribution, not only has large support (as proven, somewhat implicitly, in [6] and explicitly in [3] and [1]), but also has a large min-entropy bound. (Recall that the support of a distribution is the set of points with non-zero probability.) It follows that every k-wise independent distribution must be far from any distribution that has a small support, and thus be far from any such ϵ -bias distribution. Recall that a distribution Z has min-entropy m if m is the maximal real such that $\Pr[Z = \alpha] \leq 2^{-m}$ holds for every α . (Note that min-entropy is equivalent to $-\log_2 \max_{x \in \{0,1\}^n} D_Z(x)$.)

Lemma 3.1 For every n and every even k, any k-wise independent distribution over $\{0,1\}^n$ has min-entropy at least $-\log_2(k^k n^{-k/2}) = k \log_2(\sqrt{n}/k)$.

Let us first see how to prove Theorem 2.2, using Lemma 3.1. First we observe that a distribution Y that has min-entropy m must be at distance at least 1/2 from any distribution X that has support of size at most $2^m/2$. This follows because

$$\begin{split} \Delta(Y,X) &\geq & \mathsf{Pr}[Y \in (\{0,1\}^n \setminus \mathrm{support}(X))] \\ &= & 1 - \sum_{\alpha \in \mathrm{support}(X)} \mathsf{Pr}[Y = \alpha] \\ &\geq & 1 - |\mathrm{support}(X)| \cdot 2^{-m} \geq \frac{1}{2}. \end{split}$$

Now, letting X be an ϵ -bias distribution (i.e., having bias at most ϵ on every non-empty subset) of support $(n/\epsilon)^2$ and using Lemma 3.1 (while observing that $\epsilon > 2k^{k/2}/n^{(k/4)-1}$ implies $(n/\epsilon)^2 < 2^m/2$ for $m = \log_2(n^{k/2}/k^k)$), Theorem 2.2 follows. In fact we can derive the following corollary.

Corollary 3.2 For every n, every even k, and for every k-wise independent distribution Y, if distribution X has support smaller than $n^{k/2}/2k^k$ then $\Delta(X,Y) \geq \frac{1}{2}$.

Proof of Lemma 3.1: Let $Y = Y_1 \cdots Y_n$ be a k-wise independent distribution, and α be a string maximizing $\Pr[Y = \alpha]$. The key observation is that we may assume, without loss of generality (by XORing Y with α), that α is the all-zero string. Now, the lemma follows by applying a standard tail inequality for the sum of k-wise independent variables Y_1, \ldots, Y_n . Specifically, using the generalized Chebychev Inequality and defining $Z_i \stackrel{\text{def}}{=} Y_i - 0.5$, we have:

$$\begin{aligned} \Pr[(\forall i) \ Y_i = 0] &= \Pr\left[\sum_{i=1}^n Y_i = 0\right] \\ &\leq \Pr\left[\left|\sum_{i=1}^n Z_i\right| \ge \frac{n}{2}\right] \\ &\leq \frac{\mathsf{E}\left[(\sum_i Z_i)^k\right]}{(n/2)^k}. \end{aligned}$$

Next, we use a crude bound on the k-th moment of the sum of the Z_i 's, which follows from their k-wise independence. Specifically, we first write

$$\mathsf{E}\left[\left(\sum_{i} Z_{i}\right)^{k}\right] = \sum_{i_{1},\dots,i_{k} \in [n]} \mathsf{E}[Z_{i_{1}}\cdots Z_{i_{k}}].$$
(1)

Observe that all (r.h.s) terms in which some index appears only once are zero (i.e., if for some j and all $h \neq j$ it holds that $i_j \neq i_h$ then $\mathsf{E}[\prod_h Z_{i_h}] = \mathsf{E}[Z_{i_j}] \cdot \mathsf{E}[\prod_{h \neq j} Z_{i_h}] = 0$). All the remaining terms are such that each index appears at least twice. The number of these terms is smaller than $\binom{n}{k/2} \cdot (k/2)^k < (k/2)^k \cdot n^{k/2}$, and each contributes at most $1/2^k < 1$ to the sum (because each Z_i resides in $[\pm 0.5]$). Thus, the expression in Eq. (1) is strictly smaller than $(k/2)^k \cdot n^{k/2}$. The lemma follows (because $\mathsf{Pr}[(\forall i) Y_i = 0] \leq (k/2)^k \cdot n^{k/2}/(n/2)^k$).

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